

# 30V Half Bridge Dual N-Channel Enhancement Mode Power MOSFET

## Description

The MJB301Q is designed to provide a high efficiency synchronous buck power stage with optimal layout and board space utilization. It includes two specialized MOSFETs in a dual Power DFN3X3 package. The Q1 "High Side" MOSFET is designed to minimize switching losses. The Q2 "Low Side" MOSFET uses advanced trench technology and design to provide excellent  $R_{DS(ON)}$  with low gate charge.

### General Features

#### Q1 "High Side" MOSFET

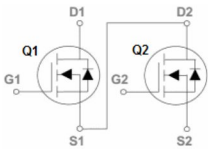
- ◆  $V_{DS}=30V, I_D=15A$   
 $R_{DS(ON)}<9m\Omega$  @  $V_{GS}=10V$   
 $R_{DS(ON)}<14m\Omega$  @  $V_{GS}=4.5V$
- ◆ Excellent gate charge x  $R_{DS(ON)}$  product(FOM)
- ◆ Very low on-resistance  $R_{DS(on)}$
- ◆ 150 °C operating temperature
- ◆ Pb-free lead plating
- ◆ 100% UIS tested

#### Q2 "Low Side" MOSFET

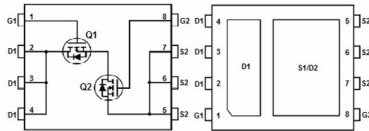
- $V_{DS}=30V, I_D=20A$   
 $R_{DS(ON)}<8.5m\Omega$  @  $V_{GS}=10V$   
 $R_{DS(ON)}<22m\Omega$  @  $V_{GS}=4.5V$

### Application

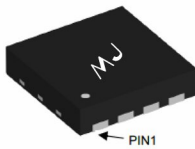
- ◆ Compact DC/DC converter applications



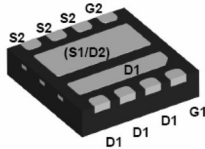
Schematic diagram



Pin Assignment



Top View



Bottom View

100% UIS TESTED! 100% ΔVds TESTED!

### Package Marking and Ordering Information

Device Marking	Device	Device Package	Reel Size	Tape width	Quantity
MJB301Q	MJB301Q	DFN3X3-8L	-	-	-

### Absolute Maximum Ratings (Tc =25 °Cunless otherwise noted)

Parameter		Symbol	Q1	Q2	Unit
Drain-Source Voltage		$V_{DS}$	30	30	V
Gate-Source Voltage		$V_{GS}$	±20	±20	V
Drain Current-Continuous (Note 2)	$T_A=25^{\circ}C$	$I_D$	15	20	A
	$T_A=100^{\circ}C$	$I_D$	10.6	14.1	A
Drain Current -Pulsed (Note 1)		$I_{DM}$	60	80	A
Power Dissipation	$T_A=25^{\circ}C$	$P_D$	18	20	W
Operating Junction and Storage Temperature Range		$T_J, T_{STG}$	-55 To 150	-55 To 150	°C

### Thermal Characteristic

Parameter	Symbol	Typ	Max	Unit
Thermal Resistance,Junction-to-Case (Note 2) (Q1)	$R_{\theta JC}$	6.5	7	V
Thermal Resistance,Junction-to-Case (Note 2) (Q1)	$R_{\theta JC}$	6	6.3	V

Q1 Electrical Characteristics (T<sub>A</sub>=25°C unless otherwise noted)

Parameter	Symbol	Condition	Min	Typ	Max	Unit
Off Characteristics						
Drain-Source Breakdown Voltage	BV <sub>DSS</sub>	V <sub>GS</sub> =0V I <sub>D</sub> =250μA	30	-	-	V
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	V <sub>DS</sub> =30V,V <sub>GS</sub> =0V	-	-	1	μA
Gate-Body Leakage Current	I <sub>GSS</sub>	V <sub>DS</sub> =±20V,V <sub>GS</sub> =0V	-	-	±100	nA
On Characteristics <sup>(Note 3)</sup>						
Gate Threshold Voltage	V <sub>GS(th)</sub>	V <sub>DS</sub> =V <sub>GS</sub> ,I <sub>D</sub> =250μA	1.0	1.5	2.2	V
Drain-Source On-State Resistance	R <sub>DS(ON)</sub>	V <sub>GS</sub> =10V, I <sub>D</sub> =10A	-	7.5	9	mΩ
		V <sub>GS</sub> =4.5V, I <sub>D</sub> =10A	-	10.2	14	mΩ
Forward Transconductance	g <sub>FS</sub>	V <sub>DS</sub> =5V,I <sub>D</sub> =10A	-	20	-	S
Dynamic Characteristics <sup>(Note 4)</sup>						
Input Capacitance	C <sub>iss</sub>	V <sub>DS</sub> =15V,V <sub>GS</sub> =0V, F=1.0MHz	-	690	-	PF
Output Capacitance	C <sub>OSS</sub>		-	105	-	PF
Reverse Transfer Capacitance	C <sub>rss</sub>		-	80	-	PF
Switching Characteristics <sup>(Note 4)</sup>						
Turn-on Delay Time	t <sub>d(on)</sub>	V <sub>DD</sub> =15V, R <sub>L</sub> =0.75Ω V <sub>GS</sub> =10V,R <sub>G</sub> =3Ω	-	5	-	nS
Turn-on Rise Time	t <sub>r</sub>		-	3.5	-	nS
Turn-Off Delay Time	t <sub>d(off)</sub>		-	19	-	nS
Turn-Off Fall Time	t <sub>f</sub>		-	3.5	-	nS
Total Gate Charge	Q <sub>g</sub>	V <sub>DS</sub> =15V,I <sub>D</sub> =10A, V <sub>GS</sub> =10V	-	15	-	nC
Gate-Source Charge	Q <sub>gs</sub>		-	2.5	-	nC
Gate-Drain Charge	Q <sub>gd</sub>		-	3	-	nC
Drain-Source Diode Characteristics						
Diode Forward Voltage <sup>(Note 3)</sup>	V <sub>SD</sub>	V <sub>GS</sub> =0V,I <sub>S</sub> =10A	-		1.2	V
Diode Forward Current <sup>(Note 2)</sup>	I <sub>S</sub>		-	-	15	A
Reverse Recovery Time	t <sub>rr</sub>	T <sub>J</sub> =25°C, I <sub>F</sub> =10A di/dt=100A/μs <sup>(Notes)</sup>	-	19	-	nS
Reverse Recovery Charge	Q <sub>rr</sub>		-	10	-	nC

Notes:

- ① Repetitive Rating: Pulse width limited by maximum junction temperature.
- ② Surface Mounted on FR4 Board, t ≤ 10 sec.
- ③ Pulse Test: Pulse Width ≤ 300μs, Duty Cycle ≤ 2%.
- ④ Guaranteed by design, not subject to production
- ⑤ EAS condition : T<sub>J</sub>=25°C, V<sub>DD</sub>=15V, V<sub>G</sub>=10V, L=0.5mH, R<sub>g</sub>=25Ω

## Q1 Typical Electrical and Thermal Characteristics (Curves)

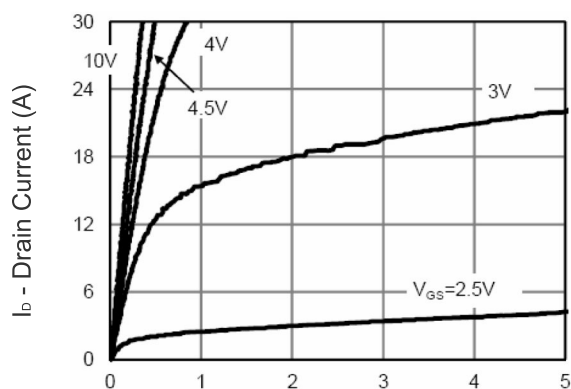


Figure 1 Output Characteristics

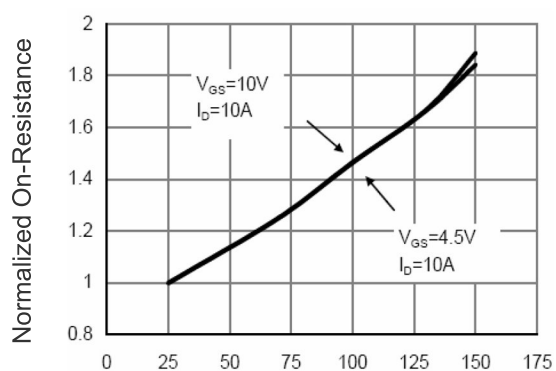


Figure 4 Rdson-Junction Temperature

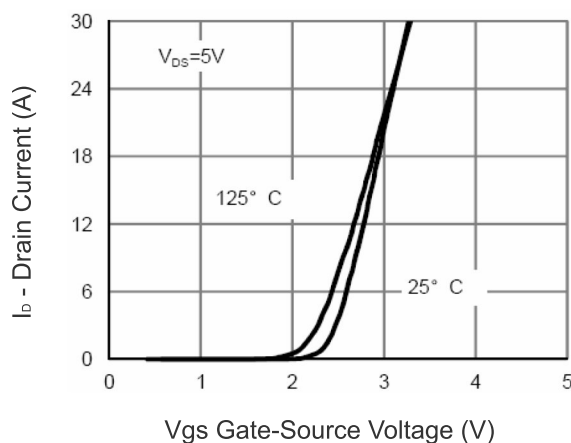


Figure 2 Transfer Characteristics

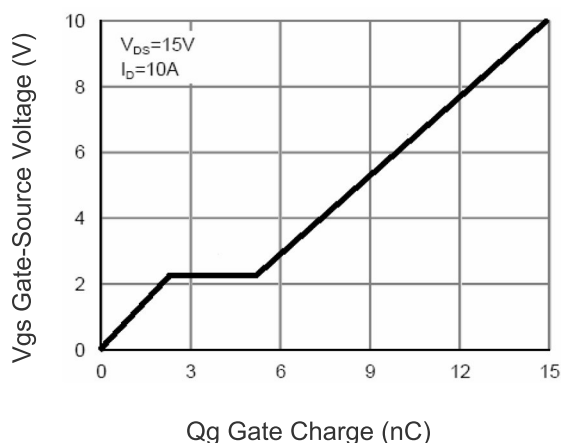


Figure 5 Gate Charge

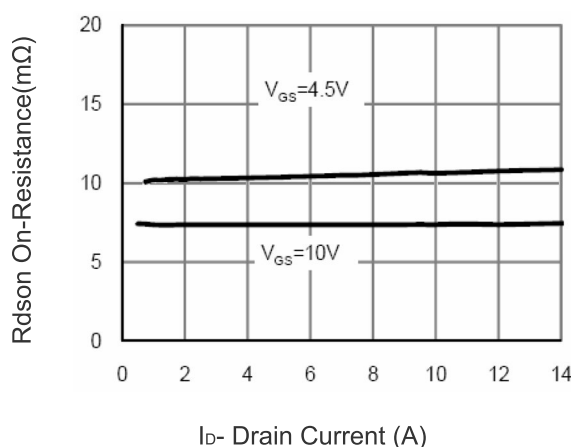


Figure 3 Rdson- Drain Current

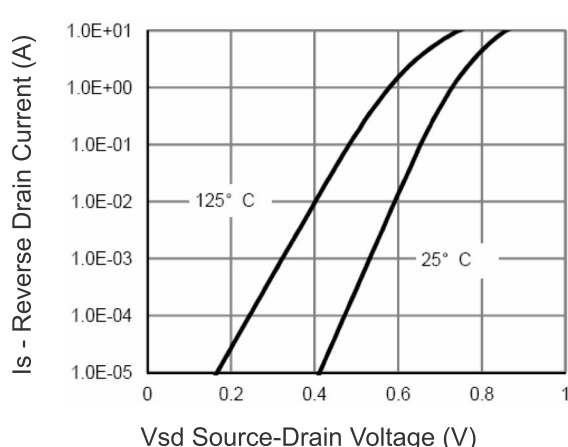
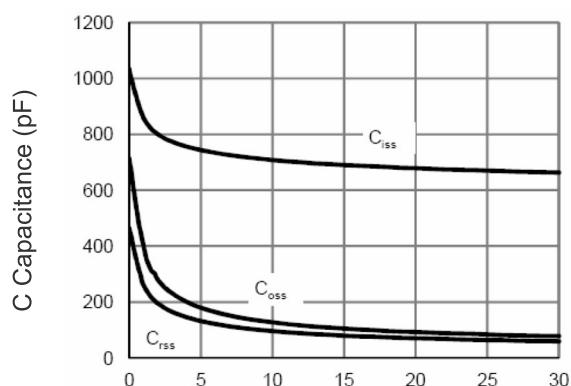
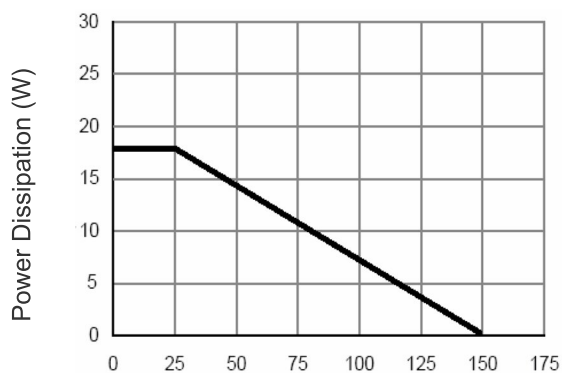


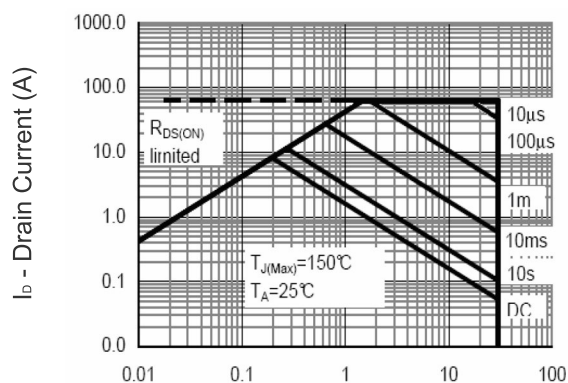
Figure 6 Source- Drain Diode Forward



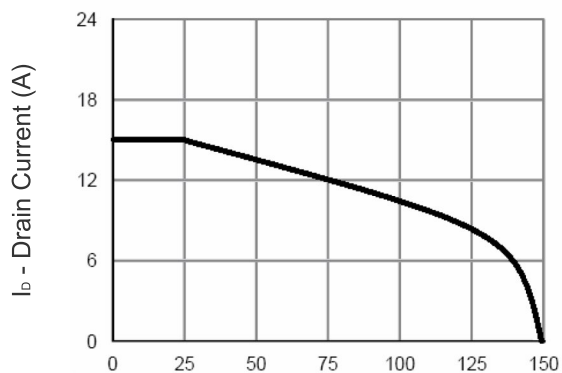
Vds Drain-Source Voltage (V)  
Figure 7 Capacitance vs Vds



TJ -Junction Temperature(°C)  
Figure 9 Power De-rating



Vds Drain-Source Voltage (V)  
Figure 8 Safe Operation Area



TJ -Junction Temperature(°C)  
Figure 10 Id Current De-rating

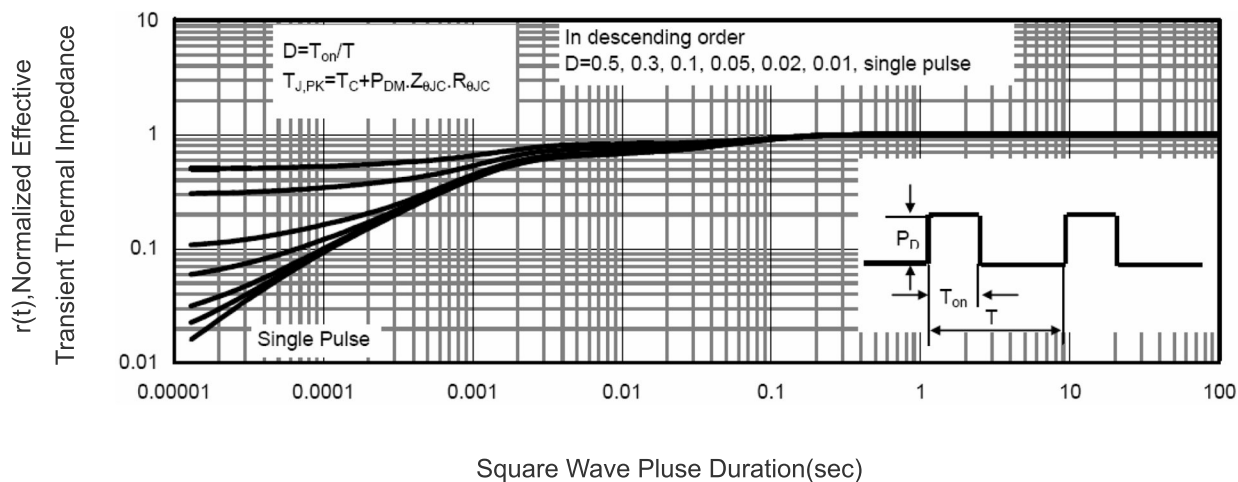


Figure 11 Normalized Maximum Transient Thermal Impedance

Q2 Electrical Characteristics (TC=25°Cunless otherwise noted)

Parameter	Symbol	Condition	Min	Typ	Max	Unit
Off Characteristics						
Drain-Source Breakdown Voltage	BV <sub>DSS</sub>	V <sub>GS</sub> =0V I <sub>D</sub> =-250μA	30	-	-	V
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	V <sub>DS</sub> =30V,V <sub>GS</sub> =0V	-	-	1	μA
Gate-Body Leakage Current	I <sub>GSS</sub>	V <sub>DS</sub> =±20V,V <sub>GS</sub> =0V	-	-	±100	nA
On Characteristics <sup>(Note 3)</sup>						
Gate Threshold Voltage	V <sub>GS(th)</sub>	V <sub>DS</sub> =V <sub>GS</sub> ,I <sub>D</sub> =250μA	1.0	1.5	2.2	V
Drain-Source On-State Resistance	R <sub>DS(ON)</sub>	V <sub>GS</sub> =10V, I <sub>D</sub> =10A	-	6.4	8.5	mΩ
		V <sub>GS</sub> =4.5V, I <sub>D</sub> =10A	-	17	22	mΩ
Forward Transconductance	g <sub>FS</sub>	V <sub>DS</sub> =5V,I <sub>D</sub> =10A	-	26	-	S
Dynamic Characteristics <sup>(Note 4)</sup>						
Input Capacitance	C <sub>iss</sub>	V <sub>DS</sub> =15V,V <sub>GS</sub> =0V, F=1.0MHz	-	1210	-	PF
Output Capacitance	C <sub>oss</sub>		-	160	-	PF
Reverse Transfer Capacitance	C <sub>rss</sub>		-	105	-	PF
Switching Characteristics <sup>(Note 4)</sup>						
Turn-on Delay Time	t <sub>d(on)</sub>	V <sub>DD</sub> =15V, R <sub>L</sub> =0.75Ω V <sub>GS</sub> =10V,R <sub>G</sub> =3Ω	-	5	-	nS
Turn-on Rise Time	t <sub>r</sub>		-	12	-	nS
Turn-Off Delay Time	t <sub>d(off)</sub>		-	19	-	nS
Turn-Off Fall Time	t <sub>f</sub>		-	6	-	nS
Total Gate Charge	Q <sub>g</sub>	V <sub>DS</sub> =15V,I <sub>D</sub> =10A, V <sub>GS</sub> =10V	-	17.5		nC
Gate-Source Charge	Q <sub>gs</sub>		-	3		nC
Gate-Drain Charge	Q <sub>gd</sub>		-	4.1		nC
Drain-Source Diode Characteristics						
Diode Forward Voltage <sup>(Note 3)</sup>	V <sub>SD</sub>	V <sub>GS</sub> =0V,I <sub>S</sub> =10A	-		1.2	V
Diode Forward Current <sup>(Note 2)</sup>	I <sub>S</sub>		-	-	20	A
Reverse Recovery Time	t <sub>rr</sub>	T <sub>J</sub> =25°C, I <sub>F</sub> =10A di/dt=100A/μs <sup>(Notes3)</sup>	-	19	-	nS
Reverse Recovery Charge	Q <sub>rr</sub>		-	10	-	nC

Notes:

- ① Repetitive Rating: Pulse width limited by maximum junction temperature.
- ② Surface Mounted on FR4 Board, t ≤ 10 sec.
- ③ Pulse Test: Pulse Width ≤ 300μs, Duty Cycle ≤ 2%.
- ④ Guaranteed by design, not subject to production
- ⑤ EAS condition : T<sub>J</sub>=25°C, V<sub>DD</sub>=15V,V<sub>G</sub>=10V,L=0.5mH,R<sub>g</sub>=25Ω

## Q2Typical Electrical and Thermal Characteristics (Curves)

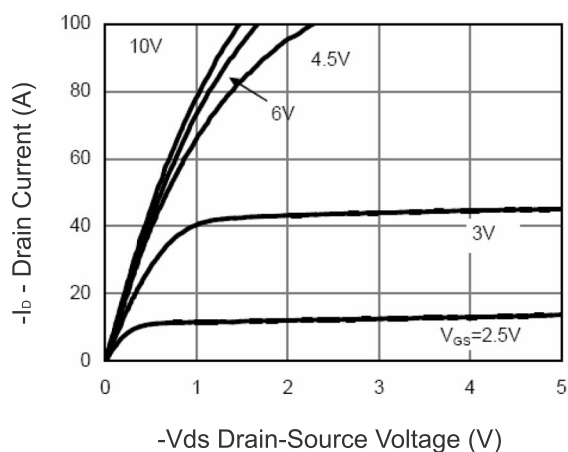


Figure 1 Output Characteristics

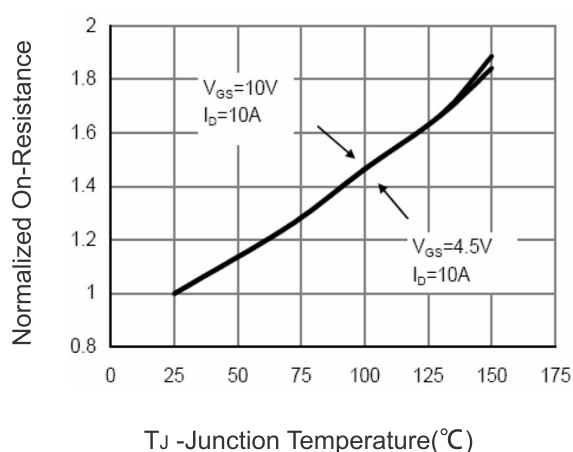


Figure 4  $R_{DS(on)}$ -Junction Temperature

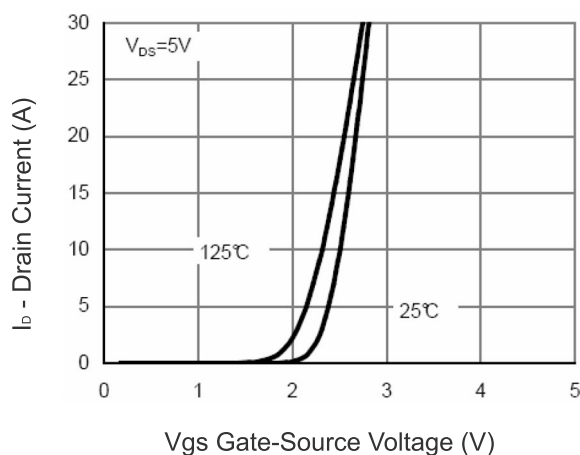


Figure 2 Transfer Characteristics

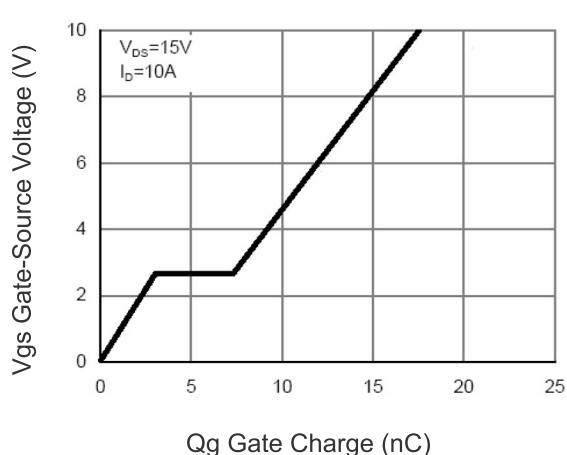


Figure 5 Gate Charge

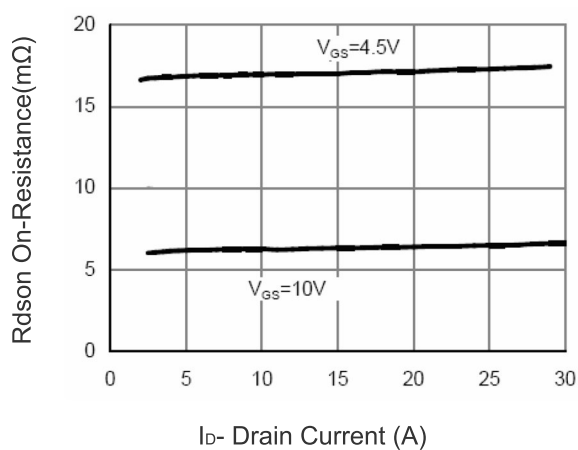


Figure 3  $R_{DS(on)}$ - Drain Current

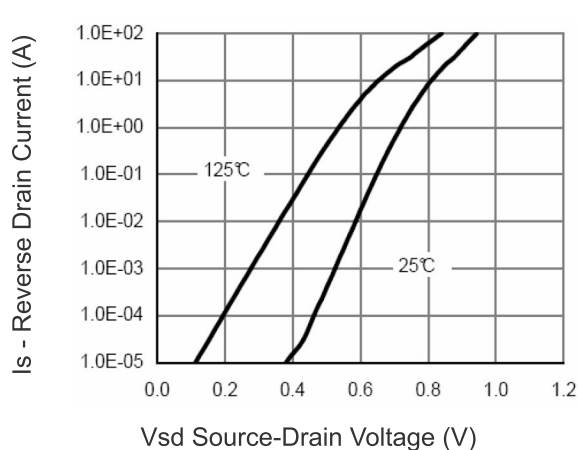
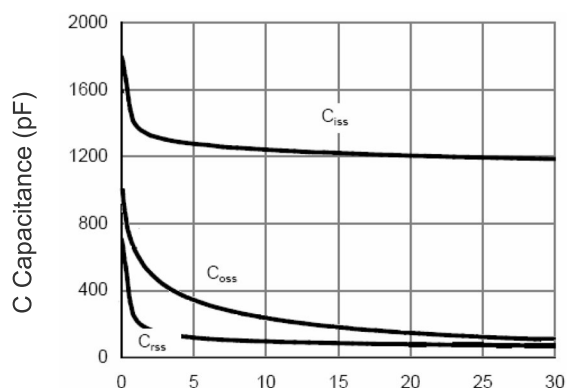
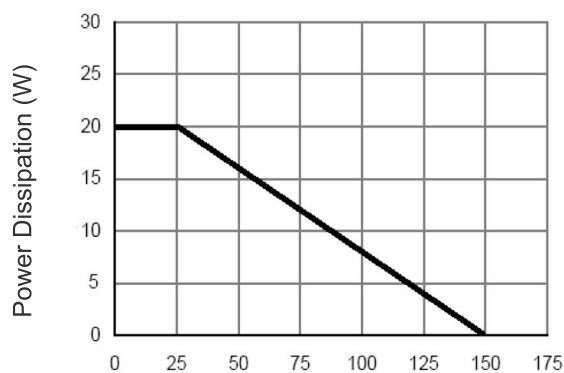


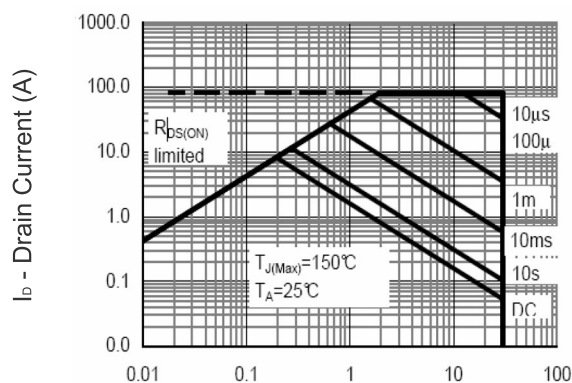
Figure 6 Source- Drain Diode Forward



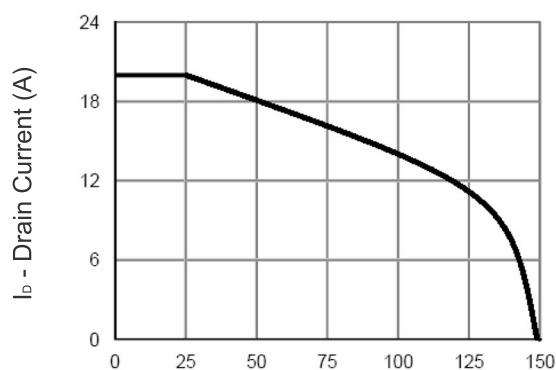
Vds Drain-Source Voltage (V)  
Figure 7 Capacitance vs Vds



TJ -Junction Temperature(°C)  
Figure 9 Power De-rating



Vds Drain-Source Voltage (V)  
Figure 8 Safe Operation Area



TJ -Junction Temperature(°C)  
Figure 10 Id Current De-rating

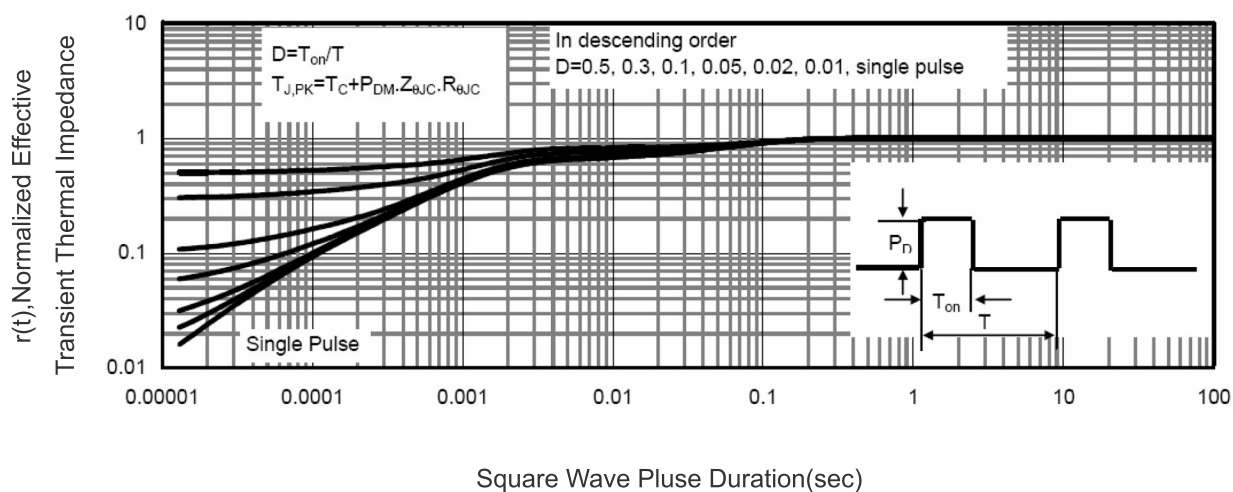
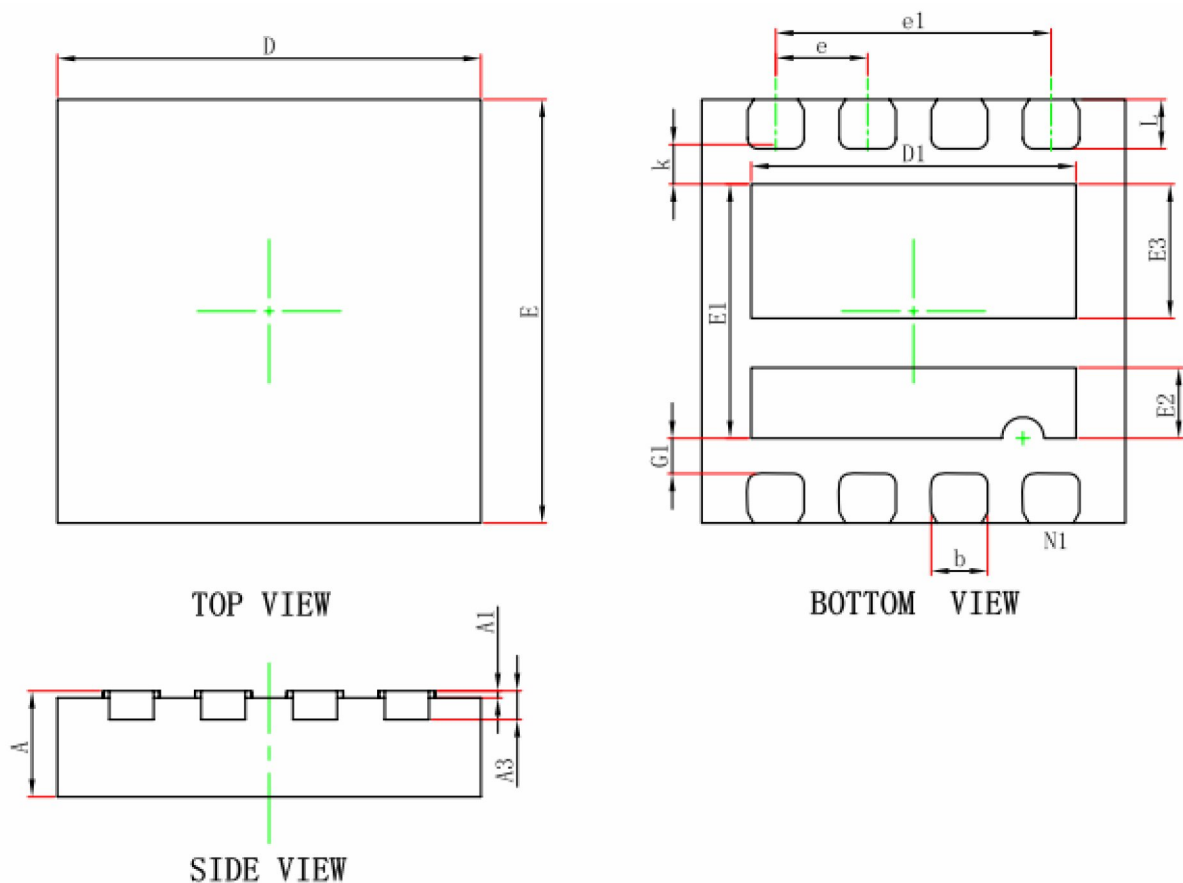


Figure 11 Normalized Maximum Transient Thermal Impedance



DFN3X3-8L Package Information



Symbol	Dimensions In Millimeters		Dimensions In Inches	
	Min.	Max.	Min.	Max.
A	0.700	0.800	0.028	0.031
A1	0.000	0.050	0.000	0.002
A3	0.203REF.		0.008REF.	
D	2.950	3.050	0.116	0.120
E	2.950	3.050	0.116	0.120
D1	2.250	2.350	0.089	0.093
E1	1.700	1.900	0.067	0.075
E2	0.450	0.550	0.018	0.022
E3	0.900	1.000	0.035	0.039
k	0.200	0.300	0.008	0.012
G1	0.200	0.300	0.008	0.012
b	0.350	0.450	0.014	0.018
e	0.650BSC		0.026BSC	
e1	1.95BSC		0.077BSC	
L	0.300	0.400	0.012	0.016



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